Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/797,191	LIN ET AL.	
Examiner	Art Unit	
Joseph Nguyen	2815	

SEARCHED			
Class	Subclass	Date	Examiner
257	99,81	5/5/2005	ИС
257	84,95	5/5/2005	JN
257	98,778	5/5/2005	JN
257	e33.056	5/5/2005	JN
257	e33.058	5/5/2005	JN
257	e33.072	5/5/2005	JN
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Subclass	Date	Examiner
	Subclass	Subclass Date

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See copy of search history	5/5/2005	JN
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